查询PBHV8118T供



PBHV8118T

180 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor Rev. 01 — 7 May 2010 Product date Product data sheet

1. **Product profile**

1.1 General description

NPN high-voltage low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package.

1.2 Features and benefits

- High voltage
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- AEC-Q101 qualified
- Small SMD plastic package

1.3 Applications

- LED driver for LED chain module
- LCD backlighting
- Automotive power management
- Hook switch for wired telecom
- Switch Mode Power Supply (SMPS)

1.4 Quick reference data

Table 1.	Quick reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CEO}	collector-emitter voltage	open base	-	-	180	V
I _C	collector current		-	-	1	А
h _{FE}	DC current gain	V _{CE} = 10 V; I _C = 50 mA	<u>[1]</u> 100	250	-	

[1] Pulse test: $t_p \leq 300 \ \mu s$; $\delta \leq 0.02$.





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2. Pinning information

Table 2.	Pinning		
Pin	Description	Simplified outline	Graphic symbol
1	base		
2	emitter		3
3	collector		
			sym021

3. Ordering information

Table 3. Order	ing information	on	
Type number	Package		
	Name	Description	Version
PBHV8118T	-	plastic surface-mounted package; 3 leads	SOT23

4. Marking

Table 4.	Marking codes	
Type num	nber	Marking code ^[1]
PBHV811	8T	LZ*

[1] * = -: made in Hong Kong

* = p: made in Hong Kong

* = t: made in Malaysia

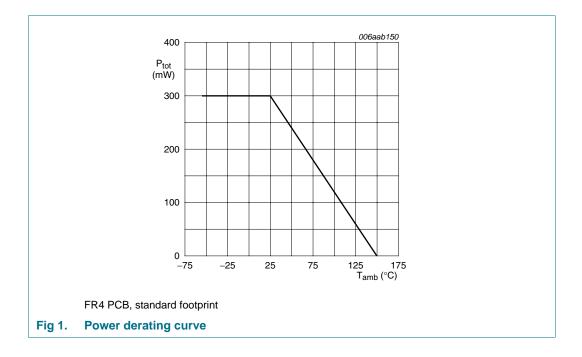
* = W: made in China

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5. Limiting values

Table 5. In accorda	Limiting values nce with the Absolute Maximu	m Rating System (IE	C 60134).		
Symbol	Parameter	Conditions	Min	Max	Unit
V _{CBO}	collector-base voltage	open emitter	-	400	V
V _{CEO}	collector-emitter voltage	open base	-	180	V
V _{EBO}	emitter-base voltage	open collector	-	6	V
I _C	collector current		-	1	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 ms$	-	2	A
I _{BM}	peak base current	single pulse; $t_p \leq 1 \text{ ms}$	-	400	mA
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$	<u>[1]</u> _	300	mW
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-55	+150	°C
T _{stg}	storage temperature		-65	+150	°C

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

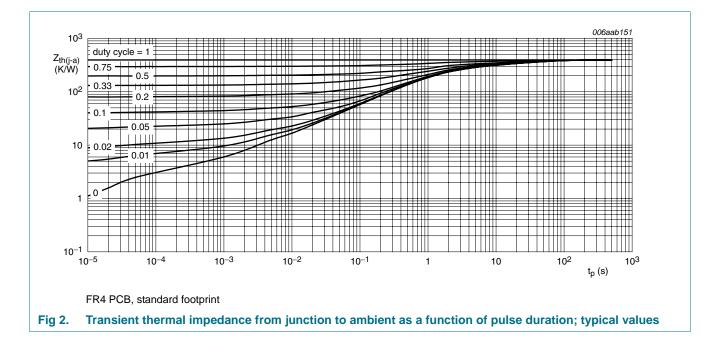


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6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	<u>[1]</u> -	-	417	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point		-	-	70	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.



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7. Characteristics

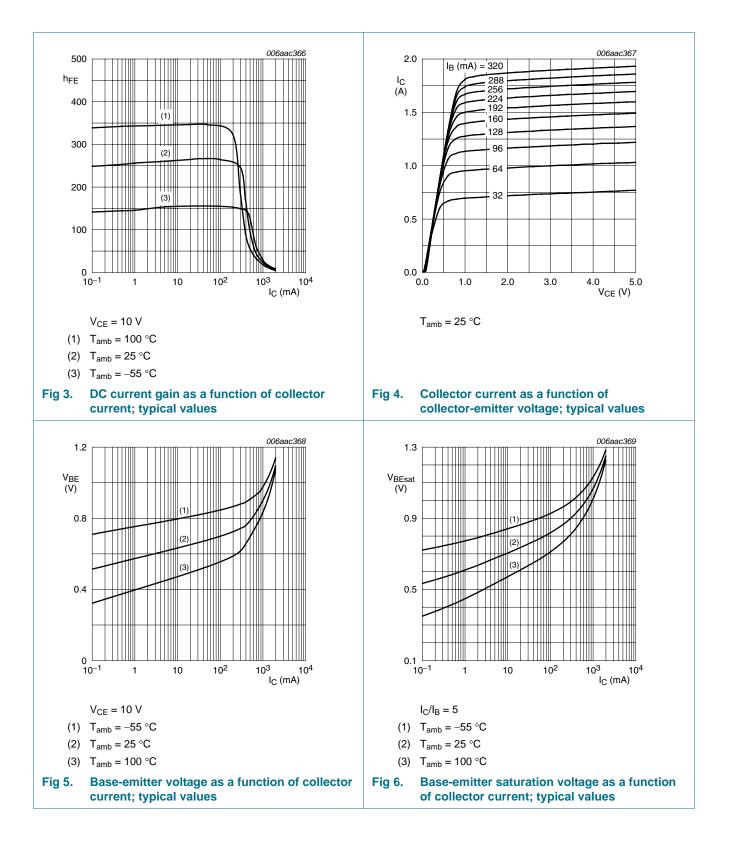
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = 144 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
	current	$\label{eq:VCB} \begin{array}{l} V_{CB} = 144 \; V; \; I_E = 0 \; A; \\ T_j = 150 \; ^\circ C \end{array}$	-	-	10	μA
I _{CES}	collector-emitter cut-off current	$V_{CE} = 144 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = 4 \text{ V}; I_{C} = 0 \text{ A}$	-	-	100	nA
h _{FE}	DC current gain	V _{CE} = 10 V	<u>[1]</u>			
		I _C = 50 mA	100	250	-	
		I _C = 100 mA	100	250	-	
		I _C = 0.5 A	50	100	-	
V _{CEsat}	collector-emitter saturation voltage	$I_{C} = 100 \text{ mA}; I_{B} = 10 \text{ mA}$	<u>[1]</u> _	40	60	mV
		$I_{C} = 100 \text{ mA}; I_{B} = 20 \text{ mA}$	<u>[1]</u> -	33	50	mV
V _{BEsat}	base-emitter saturation voltage	I _C = 0.5 A; I _B = 100 mA	<u>[1]</u> -	1	1.2	V
t _d	delay time	$V_{CC} = 6 \text{ V}; \text{ I}_{C} = 0.5 \text{ A};$	-	7	-	ns
t _r	rise time	$I_{Bon} = 0.1 \text{ A}; I_{Boff} = -0.1 \text{ A}$	-	565	-	ns
t _{on}	turn-on time		-	572	-	ns
t _s	storage time		-	1320	-	ns
t _f	fall time		-	740	-	ns
t _{off}	turn-off time		-	2060	-	ns
f _T	transition frequency	$V_{CE} = 10 \text{ V}; I_{C} = 10 \text{ mA};$ f = 100 MHz	-	30	-	MHz
C _c	collector capacitance	$\label{eq:VCB} \begin{array}{l} V_{CB} = 20 \; V; \; I_E = i_e = 0 \; A; \\ f = 1 \; MHz \end{array}$	-	5.7	-	pF
C _e	emitter capacitance	$V_{EB} = 0.5 \text{ V}; I_C = i_c = 0 \text{ A};$ f = 1 MHz	-	150	-	pF

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N 2 Sem Cohouctors

PBHV8118T

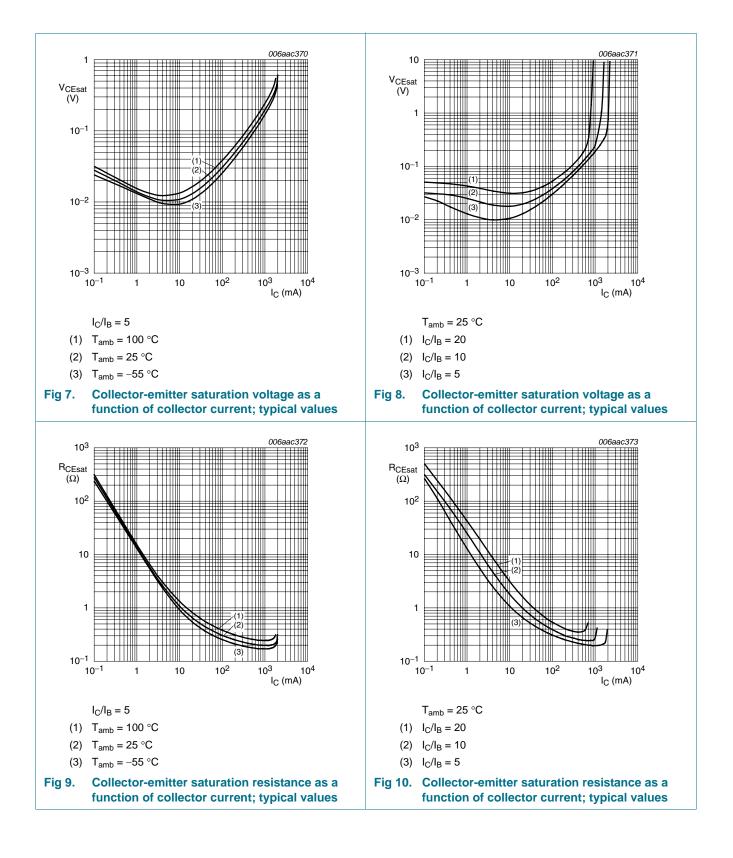
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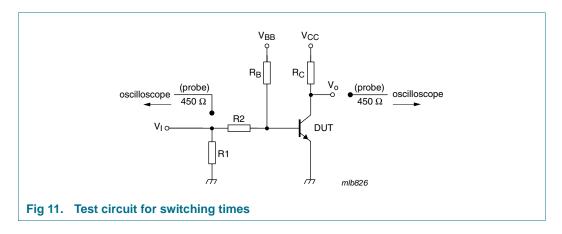
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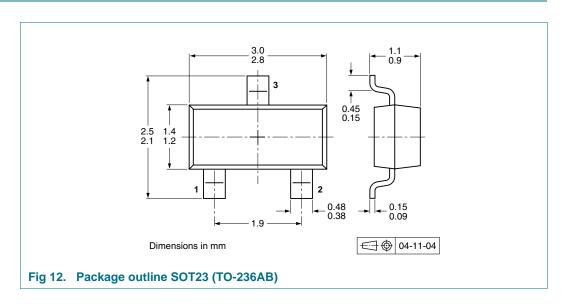
8. Test information



8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number Package		Description		Packing quantity	
			3000	10000	
PBHV8118T	SOT23	4 mm pitch, 8 mm tape and reel	-215	-235	

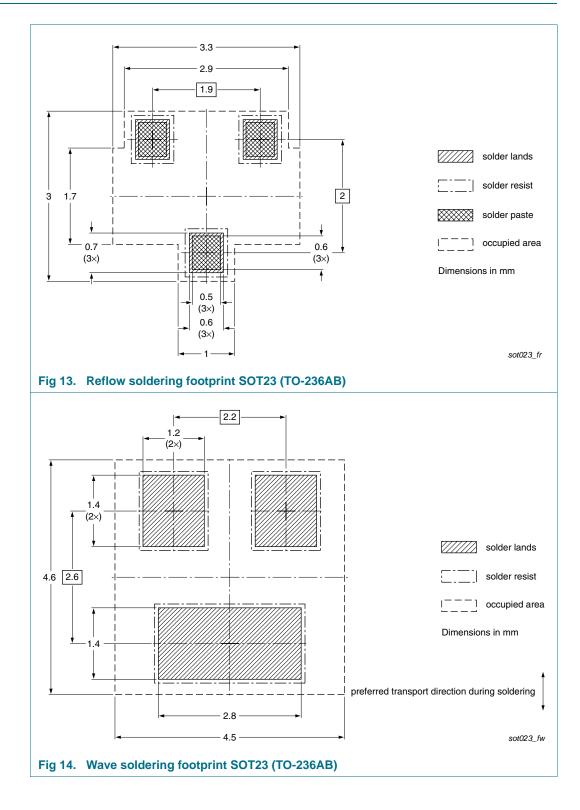
[1] For further information and the availability of packing methods, see <u>Section 14</u>.

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11. Soldering



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12. Revision history

Table 9. Revision his	Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes		
PBHV8118T v.1	20100507	Product data sheet	-	-		

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

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